# **FCC REPORT**

For LTE

Report No. ....:: CHTEW22110131 Report Verification:

Project No..... SHT2210112901EW

FCC ID.....:: 2ASWWSTARK8

Applicant .....: XINCHUANGXIN INTERNATIONAL CO.,LTD

Address.....: ROOM 605 6/F, FA YUEN COMMERCIAL BUILDING, 75-77 FA

YUEN STREET MONGKOK KL

Product Name .....: **Smart phone** 

Trade Mark ..... CORN

Model No. ....: Stark 8

Listed Model(s) .....:

FCC CFR Title 47 Part 2 Standard .....:

> FCC CFR Title 47 Part 22 FCC CFR Title 47 Part 24

FCC CFR Title 47 Part 27

Nov. 08, 2022 Date of receipt of test sample.....:

Date of testing..... Nov. 09, 2022- Nov. 23, 2022

Date of issue..... Nov. 24, 2022

Result....: **Pass** 

Compiled by

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Approved by

(position+printedname+signature)....: Manager Hans Hu

Testing Laboratory Name .....: Shenzhen Huatongwei International Inspection Co., Ltd.

Address....: 1/F, Bldg 3, Hongfa Hi-tech Industrial Park, Genyu Road, Tianliao,

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The test report merely correspond to the test sample.

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### 1. TEST STANDARDS AND REPORT VERSION

### 1.1. Applicable Standards

The tests were performed according to following standards:

<u>FCC Rules Part 2:</u> FREQUENCY ALLOCATIONS AND RADIO TREATY MATTERS; GENERAL RULES AND REGULATIONS

FCC Rules Part 22: PUBLIC MOBILE SERVICES

FCC Rules Part 24: PERSONAL COMMUNICATIONS SERVICES

FCC Rules Part 27: MISCELLANEOUS WIRELESS COMMUNICATIONS SERVICES

ANSI C63.26: 2015: American National Standard for Compliance Testing of Transmitters Used in Licensed Radio Services

KDB 971168 D01 Power Meas License Digital Systems v03: MEASUREMENT GUIDANCE FOR CERTIFICATION OF LICENSED DIGITAL TRANSMITTERS

### 1.2. Report version information

Revision No.	Date of issue	Description
N/A	2022-11-24	Original

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# 2. TEST DESCRIPTION

Section	Test Item	Section in CFR 47	Result #1	Test Engineer
5.1	Conducted Output Power	Part 2.1046 Part 22.913(a) Part 24.232(c) Part 27.50	Pass	Tiancheng Huang
5.2	Peak-to-Average Ratio	Part 24.232 Part 27.50	Pass	Tiancheng Huang
5.3	99% Occupied Bandwidth & 26 dB Bandwidth	Part 2.1049 Part 22.917(b) Part 24.238(b) Part 27.53	Pass	Tiancheng Huang
5.4	Band Edge	Part 2.1051 Part 22.917 Part 24.238 Part 27.53	Pass	Tiancheng Huang
5.5	Conducted Spurious Emissions	Part 2.1051 Part 22.917 Part 24.238 Part 27.53	Pass	Tiancheng Huang
5.6	Frequency stability vs temperature	Part 2.1055(a)(1)(b) Part 22.355 Part 24.235 Part 27.54	Pass	Tiancheng Huang
5.7	Frequency stability vs voltage	Part 2.1055(d)(1)(2) Part 22.355 Part 24.235 Part 27.54	Pass	Tiancheng Huang
5.8	ERP and EIRP	Part 22.913(a) Part 24.232(b) Part 27.50	Pass	Pan Xie
5.9	Radiated Spurious Emissions	Part 2.1053 Part 22.917 Part 24.238 Part 27.53	Pass	Pan Xie

Note:

#1: The test result does not include measurement uncertainty value

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## 3. **SUMMARY**

### 3.1. Client Information

Applicant:	XINCHUANGXIN INTERNATIONAL CO.,LTD
Address:	ROOM 605 6/F, FA YUEN COMMERCIAL BUILDING, 75-77 FA YUEN STREET MONGKOK KL
Manufacturer:	Shenzhen Chiteng Technology Co.,LTD
Address:	Second Floor,Area A, Building 4, Huiye Technology Workshop, Guanguang Road, Tangjia Community, Gongming Street, Guangming New District, Shenzhen, Guangdong

## 3.2. Product Description

Main unit information:	Main unit information:				
Product Name:	Smart phone				
Trade Mark:	CORN				
Model No.:	Stark 8				
Listed Model(s):	-				
Power supply:	DC 3.85V from Battery				
Hardware version:	G2062F-MR-V1.0				
Software version:	CORN_Stark_8_S65408_V01				
Accessory unit information:					
Battery information:	3.85Vdc, 3700mAh				
Adapter information:	Model: Input: AC100-240V, 50/60Hz, A Output: 5.0Vdc, mA				

## 3.3. Radio Specification Description

	⊠ FDD Band 2	⊠ FDD	Band 4	⊠ FDD Band 5
Support Operating Band:	⊠ FDD Band 7	⊠ FDD	Band 12	⊠ FDD Band 17
	⊠ FDD Band 66			
Operating Frequency Range:	Please refer to note #2			
Channel bandwidth:	Please refer to note #3			
Uplink Modulation type:	⊠ QPSK	⊠ 16QAM	☐ 64QAM	☐ 256QAM
Downlink Modulation type:	⊠ QPSK	⊠ 16QAM	⊠ 64QAM	☐ 256QAM
Antenna type:	Interna Antenna			
Antenna gain #4:	Band 2: -1.5dBi; Band 4: -1.8dBi; Band 5: -2.5dBi; Band 7: -1.5dBi; Band 12: 2.5dBi; Band 17: 2.5dBi; Band 66: -1.8dBi;			

Note:

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- O 🔯: means that this feature is supported; 🗀: means that this feature is not supported
- O #2: Operating frequency range is as follow:

LTE Band	Uplink frequency	Downlink frequency
FDD Band 2	1850.7 – 1909.3 MHz	1930.7 – 1989.3 MHz
FDD Band 4	1710.7 – 1754.3 MHz	2110.7 – 2154.3 MHz
FDD Band 5	824.7 - 848.3 MHz	869.7 – 893.3 MHz
FDD Band 7	2502.5 – 2567.5 MHz	2622.5 – 2687.5 MHz
FDD Band 12	699.7 – 715.3 MHz	729.7 – 745.3 MHz
FDD Band 17	706.5 – 713.5 MHz	736.5 – 743.5 MHz
FDD Band 66	1710.7 – 1779.3 MHz	2110.7 – 2179.3 MHz

O Supported channel bandwidth is as follow:

LTE Band	1.4MHz	3MHz	5MHz	10MHz	15MHz	20MHz
FDD Band 2	√	√	√	√	√	√
FDD Band 4	√	√	√	√	√	√
FDD Band 5	√	√	√	√	-	-
FDD Band 7	-	-	√	√	√	√
FDD Band 12	√	√	√	√	-	-
FDD Band 17	-	-	√	√	-	-
FDD Band 66	√	√	√	√	√	√

<sup>√:</sup> means that this feature is supported; -: means that this feature is not supported

O #4: The antenna gain is provided by the applicant, and the applicant should be responsible for its authenticity, HTW lab has not verified the authenticity of its information

## 3.4. Testing Laboratory Information

Laboratory Name	Shenzhen Huatongwei International Inspection Co., Ltd.			
Laboratory Location	1/F, Bldg 3, Hongfa Hi-tech Industrial Park, Genyu Road, Tianliao, Gongming, Shenzhen, China			
Connect information:	Tel: 86-755-26715499 E-mail: cs@szhtw.com.cn http://www.szhtw.com.cn			
Qualifications	Type Accreditation Number			
Qualifications	FCC	762235		

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# 4. TEST CONFIGURATION

## 4.1. Test frequency list

FDD Band 2	Test Frequency	Bandwidth	NuL	Frequency of	N <sub>DL</sub>	Frequency of
	ID	[MHz]	1102	Uplink [MHz]		Downlink
		1.4	18607	1850.7	607	[MHz] 1930.7
		3	18615	1851.5	615	1931.5
	Low Range	5 10	18625 18650	1852.5 1855	625 650	1932.5 1935
		15 <sup>[1]</sup>	18675	1857.5	675	1937.5
	MEA Down	20 [1]	18700	1860	700	1940
	Mid Range	1.4/3/5/10 15 <sup>[1]</sup> /20 <sup>[1]</sup>	18900	1880	900	1960
		1.4	19193	1909.3	1193	1989.3
		3 5	19185 19175	1908.5 1907.5	1185 1175	1988.5 1987.5
	High Range	10	19175	1907.5	1175	1987.5
		15 [1]	19125	1902.5	1125	1982.5
		20 [1]	19100	1900	1100	1980
	NOTE 1: Bandwidth 36.101 [2	for which a relaxati 7] Clause 7.3) is alk	on of the spe owed.	cified UE receiver :	sensitivity re	quirement (TS
FDD Band 4	Test Frequency ID	Bandwidth	NuL	Frequency of	N <sub>DL</sub>	Frequency of
1 DD Daliu 4	Test Frequency ID	[MHz]		Uplink [MHz]		Downlink [MHz]
		1.4 3	19957 19965	1710.7 1711.5	1957 1965	2110.7 2111.5
	Law Donne	5	19975	1712.5	1975	2112.5
	Low Range	10	20000	1715	2000	2115
		15 20	20025 20050	1717.5 1720	2025 2050	2117.5 2120
	Mid Range	1.4/3/5/10/15/20	20050	1732.5	2050	2120
	artungo	1.4	20393	1754.3	2393	2154.3
		3	20385	1753.5	2385	2153.5
	High Range	5 10	20375 20350	1752.5 1750	2375 2350	2152.5 2150
		15	20325	1747.5	2325	2147.5
		20	20300	1745	2300	2145
FDD Band 5	Test Frequency ID	Bandwidth [MHz]	N <sub>UL</sub>	Frequency of Uplink [MHz]	N <sub>DL</sub>	Frequency of Downlink [MHz]
		1.4	20407	824.7	2407	869.7
	Low Range	3	20415	825.5	2415	870.5
	Low Range	5	20425	826.5	2425	871.5
		10 [1]	20450	829	2450	874
	Mid Range	1.4/3/5 10 <sup>[1]</sup>	20525	836.5	2525	881.5
		1.4	20643	848.3	2643	893.3
	1	3	20635	847.5	2635	892.5
	High Range	-	20225			
	High Range	5 10 <sup>[1]</sup>	20625	846.5 844	2625 2600	891.5 889
	NOTE 1: Bandwidth f	10 <sup>[1]</sup>	20600 n of the spec	844	2600	889
FDD Band 7	NOTE 1: Bandwidth f	10 <sup>[1]</sup> or which a relaxation	20600 n of the spec	844	2600	889 irement (TS
FDD Band 7	NOTE 1: Bandwidth 1 36.101 [27	10 [1] or which a relaxation Clause 7.3) is allow Bandwidth [MHz]	20600 n of the specwed.  NuL  20775	844 ified UE receiver se  Frequency of Uplink [MHz]  2502.5	N <sub>DL</sub>	Frequency of Downlink [MHz] 2622.5
FDD Band 7	NOTE 1: Bandwidth 1 36.101 [27	To rwhich a relaxation or which a relaxation or which a relaxation or clause 7.3) is allow the control of the c	20600 n of the specwed.  NuL  20775 20800	844 ified UE receiver se  Frequency of Uplink [MHz]  2502.5 2505	N <sub>DL</sub> 2775 2800	Frequency of Downlink [MHz] 2622.5 2625
FDD Band 7	NOTE 1: Bandwidth 1 36.101 [27	10 [1] or which a relaxatio ] Clause 7.3) is allou  Bandwidth [MHz]	20600 n of the spec wed.  NuL  20775 20800 20825	Frequency of Uplink [MHz] 2502.5 2507.5	2600 nsitivity required N <sub>DL</sub> 2775 2800 2825	Frequency of Downlink [MHz] 2622.5 2625.2627.5
FDD Band 7	NOTE 1: Bandwidth 1 36.101 [27	Bandwidth [MHz]  5 10 10 15 15 10 15 10 15 10 17 17 17 17 17 17 17 17 17 17 17 17 17	Nut. 20775 20800 20825 20850	### Receiver se ### Frequency of Uplink [MHz] ### 2502.5	2600 nsitivity required N <sub>DL</sub> 2775 2800 2825 2850	889
FDD Band 7	NOTE 1: Bandwidth 1 36.101 [27	10 <sup>11</sup> or which a relaxatio glause 7.3) is allow  Bandwidth [MHz]  5 10 15 20 <sup>11</sup> 5/10/15 20 <sup>10</sup>	Nut. 20775 20800 20825 20850 21100	844   Iffied UE receiver se   Frequency of   Uplink [MHz]   2502.5   2507.5   2507.5   2510   2535	2600 nsitivity requ  N <sub>DL</sub> 2775 2800 2825 2850 3100	889
FDD Band 7	NOTE 1: Bandwidth 1 36.101 [27  Test Frequency ID  Low Range  Mid Range	10 <sup>11</sup> or which a relaxatio   Clause 7.3) is allo   Bandwidth [MHz]   5   10   15   20   11   5/10/15   20   11   5   5/10/15   5   5   5   5   5   5   5   5   5	20600 n of the spec wed.  NuL 20775 20800 20825 20850 21100 21425	### 844    Frequency of Uplink [MHz]   2502.5   2505   2510   2535   2567.5   267.5	2600 nsitivity requ  N <sub>DL</sub> 2775  2800  2825  2850  3100  3425	889
FDD Band 7	NOTE 1: Bandwidth 1 36.101 [27	10 <sup>11</sup> or which a relaxatio   Clause 7.3) is allo   Bandwidth [MHz]   5	20600 n of the spec wed.  Nut.  20775 20800 20825 20850 21100 21425 21400 21375	### 844    Frequency of Uplink [MHz]   2502.5   2507.5   2510   2535   2567.5   2567.5   2567.5   2567.5   2567.5   2567.5   2565	2600 nsitivity requ  NbL  2775 2800 2825 2850 3100 3425 3400 3375	889
FDD Band 7	NOTE 1: Bandwidth 1 36.101 [27  Test Frequency ID  Low Range  Mid Range  High Range	10 <sup>11</sup> or which a relaxatio   Clause 7.3) is allow   Bandwidth [MHz]   5   10   15   20 <sup>11</sup>   5/10/15   20 <sup>11</sup>   5   10   15   10   15   10   15   10   15   10   15   10   15   10   15   10   15   10   15   20 <sup>11</sup>   10   20 <sup>11</sup>   20 <sup>11</sup>	20600 n of the spec wed.  NuL  20775 20800 20825 20850 21100 21425 21400 21375 21350	844	2600 nsitivity requ  N <sub>DL</sub> 2775 2800 2825 2850 3100 3425 3400 3375 3350	889
FDD Band 7	NOTE 1: Bandwidth 1 36.101 [27  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth 1	10 <sup>11</sup> or which a relaxatio   Clause 7.3) is allow   Bandwidth [MHz]   5   10   15   20 <sup>11</sup>   5/10/15   20 <sup>11</sup>   5   10   15   10   15   10   15   10   15   10   15   10   15   10   15   10   15   10   15   20 <sup>11</sup>   10   20 <sup>11</sup>   20 <sup>11</sup>	20600 n of the specwed.  NuL 20775 20800 20825 20850 21100 21425 21400 21375 21350 on of the speci	844	2600 nsitivity requ  N <sub>DL</sub> 2775 2800 2825 2850 3100 3425 3400 3375 3350	889
	NOTE 1: Bandwidth 1 36.101 [27  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth 1	Ho III or which a relaxation   Clause 7.3) is allow   Bandwidth [MHz]     5     10     15     20 III     5/10/15     20 III     5     10     15     20 III     15     10     15     10     15     20 III     15     20 III     15     20 III     15     20 III     3     4     5     5     10     15     20 III     15     20 III     3     4     5     5     6     7     7     8     9     9     9     10	20600 n of the spec wed.  Nut.  20775 20800 20825 20850 21100 21425 21400 21350 n of the speciwed.	### Red   ### Re	2600 nsitivity requi	889
	NOTE 1: Bandwidth 1 36.101 [27  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth 1 36.101 [27  Table 4.3.1.1.12-1:	10 <sup>11</sup> or which a relaxatio  [ Clause 7.3) is allo    Bandwidth [MHz]     5     10     15     20 <sup>11</sup>   5     10     5     10     5     10     15     20 <sup>11</sup>   5     10     15     20 <sup>11</sup>   20	20600 n of the specwed.  NuL  20775 20800 20825 20850 21100 21425 21400 21350 n of the speciwed.	844	2600 nsitivity requi  NoL  2775 2800 2825 2850 3100 3425 3400 3425 3400 sitivity requi  width for o	889
	NOTE 1: Bandwidth 1 36.101 [27  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth 1 36.101 [27	Ho III or which a relaxation   Clause 7.3) is allow   Bandwidth [MHz]     5     10     15     20 III     5/10/15     20 III     5     10     15     20 III     15     10     15     10     15     20 III     15     20 III     15     20 III     15     20 III     3     4     5     5     10     15     20 III     15     20 III     3     4     5     5     6     7     7     8     9     9     9     10	20600 n of the specwed.  NuL  20775 20800 20825 20850 21100 21425 21405 21375 21350 n of the speciwed.  NuL	844	2600   NpL   NpL   2775   2805   2825   2825   2850   3100   3425   3450   3350   nsitivity requirements   NpL	889
	NOTE 1: Bandwidth 1 36.101 [27  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth 1 36.101 [27  Table 4.3.1.1.12-1:	Ho III for which a relaxation   Clause 7.3) is allow   Bandwidth [MHz]     5	20600 n of the specwed.  NuL  20775 20800 20825 20850 21100 21425 21405 21350 n of the speciwed.  NuL  23017	844	2600 nsitivity requi  NoL  2775 2800 2825 2850 3100 3425 3400 3375 3350 3350 ssitivity requi  width for o  NoL	889
	NOTE 1: Bandwidth 1 36.101 [27  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth 1 36.101 [27  Table 4.3.1.1.12-1:	10 11 or which a relaxation [Clause 7.3) is allow [MHz]  Bandwidth [MHz]  5 10 15 20 11 5710/15 20 10 15 10 15 10 15 10 15 10 15 15 10 15 15 10 15 15 10 15 15 10 15 15 10 15 15 10 15 15 10 15 15 10 15 15 10 15 15 10 15 15 10 15 15 10 15 15 10 15 15 10 15 15 15 15 15 15 15 15 15 15 15 15 15	20600 nor the spec wed.  NuL  20775 20800 20825 20850 21100 21425 21376 21350 21376 21350 softhe speci wed.	844	2600   NoL   2775   2806   2825   2825   2825   3400   3375   3350   3400   3375   350   3400   350   3400   350	889
	NOTE 1: Bandwidth 1 36.101 [27  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth 1 36.101 [27  Table 4.3.1.1.12-1:	Ho III for which a relaxation   Clause 7.3) is allow   Bandwidth [MHz]     5	20600 n of the specwed.  NuL  20775 20800 20825 20850 21100 21425 21405 21350 n of the speciwed.  NuL  23017	844	2600 nsitivity requi  NoL  2775 2800 2825 2850 3100 3425 3400 3475 3350 sitivity requi  width for o  NoL	889
	NOTE 1: Bandwidth 1 36.101 [27  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth 1 36.101 [27  Table 4.3.1.1.12-1:	10 11	20600 n of the specwed.  NuL  20775 20800 20825 20850 21100 211425 21425 21350 n of the specwed.  NuL  S for E-UTR  NuL  23017 23025 23025 23025	844	2600   NpL   NpL   2775   2800   3100   3375   3350   3350   3350   Nstivity requirements   NpL   S017   S025   S035	889
	NOTE 1: Bandwidth 1 36.101 [27  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth 36.101 [27  Table 4.3.1.1.12-1:  Test Frequency ID  Low Range	10 11	20600 n of the specwed.  NuL  20775 20800 20825 20825 20825 21100 21170 21375 21350 21350 n of the speciwed.  NuL  20077 23025 23025 23095 23095	844	2600   NoL   NoL   2775   2800   2825   2850   3100   3425   3400   3375   3350   3350   Stivity requirements   NoL   5017   5025   5035   5060   5095	889
	NOTE 1: Bandwidth 1 36.101 [27  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth 1 36.101 [27  Table 4.3.1.1.12-1:  Test Frequency ID  Low Range  Mid Range	10 11	20600	## 844 ### ### ### ### ### ### ### ### ### #	2600   NpL   NpL   2775   2800   2825   2850   3100   3425   3360   3375   3350   3350   3500   5005   5005   5005   5005   5005   5005   5173	889
	NOTE 1: Bandwidth 1 36.101 [27  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth 36.101 [27  Table 4.3.1.1.12-1:  Test Frequency ID  Low Range	10 11 10 10 10 10 10 10 10 10 10 10 10 1	20600   no f the spec	844	2600 nsitivity requi  NoL  2775 2800 2825 2850 3100 3425 3400 3375 3376 3376 5017 5025 5035 5035 5095 5173 5165	889
	NOTE 1: Bandwidth 1 36.101 [27  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth 36.101 [27  Table 4.3.1.1.12-1:  Test Frequency ID  Low Range  Mid Range  High Range	10 11	NuL   2000   NuL   200775   20800   20825   20850   21100   21375   21350   21355	## 844 ### Frequency of Uplink [MHz]  2502.5 2507.5 2510 2535 2567.5 25665 2562.5 25602.5 25603 ### Frequency of Uplink [MHz]  699.7 700.5 701.5 704 707.5 715.3 714.5 713.5 711.1	2600 nsitivity requi  NpL  2775 2800 2825 2825 2825 2825 3400 3375 3350 3350 sitivity requi  width for o  NoL  5017 5025 5035 5060 5095 5173 5166 5155	889
	NOTE 1: Bandwidth 1 36.101 [27  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth 1 36.101 [27  Table 4.3.1.1.12-1:  Test Frequency ID  Low Range  Mid Range  High Range  High Range  NOTE 1: Bandwidth	10 11	20600 n of the specwed.  NuL  20775 20800 20825 20850 21100 21425 21405 21350 n of the specwed.  8 for E-UTR  NuL 23017 23025 23035 23060 23075 23155 23155 23155 23155	844	2600 nsitivity requi  NpL  2775 2800 2825 2825 2825 2825 3400 3375 3350 3350 sitivity requi  width for o  NoL  5017 5025 5035 5060 5095 5173 5166 5155	889
FDD Band 12	NOTE 1: Bandwidth 1 36.101 [27  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth 1 36.101 [27  Table 4.3.1.1.12-1:  Test Frequency ID  Low Range  Mid Range  High Range  High Range  NOTE 1: Bandwidth	10 11	NuL  20775 20800 20775 20800 20825 20825 20850 21100 21425 21375 21350 21350 8 for E-UTR  NuL  23017 23025 23036 23036 23036 23165 23155 23156 23156 23150 or of the speciallowed.	## 844 ### ### ### ### ### ### ### ### ### #	2600   NpL   NpL   2775   2800   2825   2825   2825   2825   3400   3375   3350   3350   3500   5050   5050   5050   5050   5153   5165   5155   5130   ensitivity requi	889
FDD Band 12	NOTE 1: Bandwidth 1 36.101 [27  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth 1 36.101 [27  Table 4.3.1.1.12-1:  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth 1 36.101 [27	10 11 10 ro which a relaxation [Clause 7.3) is allow [MHz]    Bandwidth [MHz]    5 10 15 20 11 5 10 15 20 11 5 10 10 10 10 10 10 10 10 10 10 10 10 10	NuL   2000   NuL   20775   20800   20825   20850   21100   21425   21305   21350   of the speciwed.   S for E-UTR   NuL   23017   23025   23035   23095   23095   23153   23155   23	844	2600   NoL   2775   2800   3425   2825   2	889
FDD Band 12	NOTE 1: Bandwidth 1 36.101 [27  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth 1 36.101 [27  Table 4.3.1.1.12-1:  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth (TS 36.10)	10 11	20600   no f the spec wed.   NuL   20775   20800   20825   20850   21100   21375   21400   21375   23025   23007   23025   23007   23025   23007   23025   23007   23025   23007   2	844	2600   NpL     NpL     2775   2800     2825   2850   3100   3425   3400   3375   3350     3400   3375   5025   5035   5035   5155   5130   ensitivity requirements   5173   5165   5130   ensitivity requirements   5755   5780     S755   S780     S755     S7	S89
FDD Band 12  FDD Band 17	NOTE 1: Bandwidth 1 36.101 [27  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth 1 36.101 [27  Table 4.3.1.1.12-1:  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth (TS 36.10)  Test Frequency ID  Low Range  Mid Range	10   11	20600   10   10   10   10   10   10   10	844	2600   NoL   2775   2800   3425   2825   2	889
FDD Band 12	NOTE 1: Bandwidth 1 36.101 [27  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth 1 36.101 [27  Table 4.3.1.1.12-1:  Test Frequency ID  Low Range  Mid Range  High Range  NOTE 1: Bandwidth (TS 36.10)	10   11	NuL   20775   20800   20825   20850   21100   21375   21350	844	2600   NpL   2775   2800   2825   2825   2825   3400   3375   3350   3350   3505   5055   5055   5150   5	S89

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Test Frequency ID	Bandwidth [MHz]	N <sub>UL</sub>	Frequency of Uplink [MHz]	N <sub>DL</sub>	Frequency of Downlink [MHz]
	1.4	131979	1710.7	66443	2110.7
	3	131987	1711.5	66451	2111.5
Low Range	5	131997	1712.5	66461	2112.5
Low Range	10	132022	1715	66486	2115
	15	132047	1717.5	66511	2117.5
	20	132072	1720	66536	2120
Mid Range Tx1	1.4/3/5/10/15/20	132322	1745	66786	2145
Mid Range	1.4/3/5/10/15/20	132422	1755	66886	2155
	1.4	132665	1779.3	67129	2179.3
	3	132657	1778.5	67121	2178.5
Paired High	5	132647	1777.5	67111	2177.5
Range <sup>2</sup>	10	132622	1775	67086	2175
	15	132597	1772.5	67061	2172.5
	20	132572	1770	67036	2170
	1.4	NA	NA	67329	2199.3
	3	NA	NA	67321	2198.5
High Range <sup>3</sup>	5	NA	NA	67311	2197.5
High Range	10	NA	NA	67286	2195
	15	NA	NA	67261	2192.5
	20	NA	NA	67236	2190

### 4.2. Descriptions of Test mode

Antenna port conducted and radiated test items were performed according to KDB 971168 D01 Power Meas. License Digital Systems and ANSI C63.26 with maximum output power.

Radiated measurements were performed with rotating EUT in different three orthogonal test planes to find the maximum emission.

Test configuration is as follow:

Test Items	Bandwidth	Modulation	RB#			
restitents	Bandwidth		1	Half	Full	
Conducted Output Power	#5	#6	0	0	0	
Peak-to-Average Ratio	#5	#6	0		0	
99% Occupied Bandwidth & 26 dB Bandwidth	#5	#6	-	-	0	
Band Edge	#5	#6	0	-	0	
Conducted Spurious Emission	#5	#6	0	-	-	
Frequency Stability	#5	#6	-	-	0	
ERP and EIRP	#5	#6	0	0	0	
Radiated Spurious Emission	#5	#6	0	-	-	

### Note:

- O #5: Test all kind of bandwith in section 3.3
- O #6: Test all kind of uplink modulation in section 3.3
- O o: means that this configuration is chosen for testing
- O -: means that this configuration is not test.
- O The device is investigatedfrom 30MHz to10 times offundamental signal for radiated spurious emission test under different bandwidth,modulations and RB size/offset in exploratory test. Subsequently, only the worst case emissions(highest bandwidth,QPSK,and 1RB0) are reported.

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### 4.3. Test sample information

Test item	HTW sample no.		
Conducted test items	Please refer to the description in the appendix report		
Radiated test items	YPHT22101129003		

Note:

Conducted test items: Conducted Output Power, Peak-Average Ratio, 99% Occupied Bandwidth & 26 dB

Bandwidth, Band Edge, Conducted Spurious Emissions, Frequency stability, ERP and

**EIRP** 

Radiated test items: Radiated Spurious Emission

## 4.4. Support unit used in test configuration and system

The EUT has been associated with peripherals and configuration operated in a manner tended to maximize its emission characteristics in a typical application.

The following peripheral devices and interface cables were connected during the measurement:

Whether support unit is used?						
✓	No					
Item	Equipment	Trade Name	Model No.	Other		
1						
2						

### 4.5. Testing environmental condition

	VN=Nominal Voltage	DC 3.85V	
Voltage	VL=Lower Voltage	DC 3.465V	
	VH=Higher Voltage	DC 4.235V	
Tanananahana	TN=Normal Temperature	25 °C	
Temperature	Extreme Temperature	From -30°C to + 50°C	
Humidity	30~60 %		
Air Pressure	950-1050 hPa		

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## 4.6. Statement of the measurement uncertainty

No.	Test Items	Measurement Uncertainty
1	Conducted Output Power	0.66
2	Peak-to-Average Ratio	-
3	99% Occupied Bandwidth & 26 dB Bandwidth	0.002%
4	Band Edge	1.68dB
5	Conducted Spurious Emissions	1.68dB
6	Frequency stability	0.02ppm
7	Radiated Spurious Emission	4.54dB for 30MHz-1GHz
	Tradition Opunious Emission	5.10dB for above 1GHz

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=1.96.

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## 4.7. Equipments Used during the Test

•	Conducted test item						
Used	Test Equipment	Manufacturer	Equipment No.	Model No.	Serial No.	Last Cal. Date (YY-MM-DD)	Next Cal. Date (YY-MM-DD)
0	Signal and spectrum Analyzer	R&S	HTWE0242	FSV40	100048	2022/08/25	2023/08/24
0	Signal & Spectrum Analyzer	R&S	HTWE0262	FSW26	103440	2022/08/25	2023/08/24
•	Spectrum Analyzer	Agilent	HTWE0286	N9020A	MY50510187	2022/08/25	2023/08/24
•	Radio communication tester	R&S	HTWE0287	CMW500	137688-Lv	2022/08/25	2023/08/24
•	Test software	Tonscend	N/A	JS1120	N/A	N/A	N/A

•	Radiated Spurious Emission						
Used	Test Equipment	Manufacturer	Equipment No.	Model No.	Serial No.	Last Cal. Date (YY-MM-DD)	Next Cal. Date (YY-MM-DD)
•	Semi-Anechoic Chamber	Albatross projects	HTWE0122	SAC-3m-01	C11121	2018/09/27	2023/09/26
•	Spectrum Analyzer	R&S	HTWE0098	FSP40	100597	2022/08/25	2023/08/24
•	Loop Antenna	R&S	HTWE0170	HFH2-Z2	100020	2021/04/06	2024/04/05
•	Broadband Horn Antenna	SCHWARZBECK	HTWE0103	BBHA9170	BBHA9170472	2020/04/27	2023/04/26
•	Ultra-Broadband Antenna	SCHWARZBECK	HTWE0123	VULB9163	538	2021/04/06	2024/04/05
•	Horn Antenna	SCHWARZBECK	HTWE0126	9120D	1011	2020/04/01	2023/03/31
•	Pre-amplifier	CD	HTWE0071	PAP-0102	12004	2022/11/04	2023/11/03
•	Broadband Preamplifier	SCHWARZBECK	HTWE0201	BBV 9718	9718-248	2022/02/28	2023/02/27
•	RF Connection Cable	HUBER+SUHNER	HTWE0120-01	6m 18GHz S Serisa	N/A	2022/02/25	2023/02/24
•	RF Connection Cable	HUBER+SUHNER	HTWE0120-02	6m 3GHz RG Serisa	N/A	2022/02/25	2023/02/24
•	RF Connection Cable	HUBER+SUHNER	HTWE0119-05	6m 3GHz RG Serisa	N/A	2022/02/25	2023/02/24
•	RF Connection Cable	HUBER+SUHNER	HTWE0120-04	6m 3GHz RG Serisa	N/A	2022/02/25	2023/02/24
•	EMI Test Software	Audix	N/A	E3	N/A	N/A	N/A

•	Auxiliary Equipment						
Used	Test Equipment	Manufacturer	Equipment No.	Model No.	Serial No.	Last Cal. Date (YY-MM-DD)	Next Cal. Date (YY-MM-DD)
•	Climate chamber	ESPEC	HTWE0254	GPL-2	N/A	2022/08/29	2023/08/28
•	DC Power Supply	Gwinstek	HTWE0274	SPS-2415	GER835793	N/A	N/A

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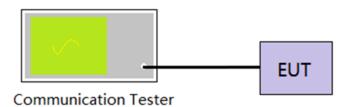
## 5. TEST CONDITIONS AND RESULTS

### 5.1. Conducted Output Power

### **LIMIT**

N/A

### **TEST CONFIGURATION**



### **TEST PROCEDURE**

- 1. The EUT output port was connected to communication tester.
- 2. Set EUT at maximum power through communication tester.
- 3. Select lowest, middle, and highest channels for each band and different modulation.
- 4. Measure the maximum burst average power.

### **TEST MODE:**

Please refer to the clause 4.2

### **TEST RESULTS**

Refer to appendix A on the section 8 appendix report

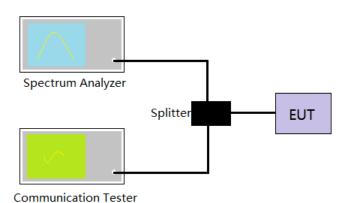
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### 5.2. Peak-to-Average Ratio

#### **LIMIT**

13dB

### **TEST CONFIGURATION**



#### **TEST PROCEDURE**

- 1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter
- 2. Set EUT in maximum power output.
- 3. Center Frequency = Carrier frequency, RBW > Emission bandwidth of signal
- 4. The signal analyzer was set to collect one million samples to generate the CCDF curve
- 5. The measurement interval was set depending on the type of signal analyzed.
  - i. For continuous signals (>98% duty cycle), the measurement interval was set to 1ms.
  - ii. For bursttransmissions, the spectrum analyzer is set to use an internal "RF Burst" trigger that issynced with an incoming pulse and the measurement interval is set to less than the duration of the "on time" of one burst to ensure that energy is only captured during a time in whichthetransmitter is operating at maximum power
- 6. Record the maximum PAPR level associated with a probability of 0.1%.

### **TEST MODE:**

Please refer to the clause 4.2

### **TEST RESULTS**

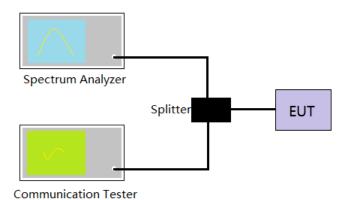
Refer to appendix B on the section 8 appendix report

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### 5.3. 99% Occupied Bandwidth & 26 dB Bandwidth

LIMIT N/A

### **TEST CONFIGURATION**



### **TEST PROCEDURE**

- 1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter
- 2. Set EUT in maximum power output.
- 3. Spectrum analyzer setting as follow:

Center Frequency= Carrier frequency, RBW=1% to 5% of the anticipated OBW, VBW= 3 \* RBW, Detector=Peak,

Trace maximum hold.

4. Record the value of 99% Occupied bandwidth and 26dB bandwidth.

### **TEST MODE:**

Please refer to the clause 4.2

### **TEST RESULTS**

Refer to appendix C on the section 8 appendix report

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### 5.4. Band Edge

### **LIMIT**

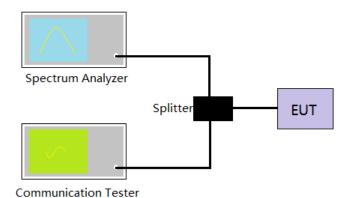
Part 24.238 and Part 22.917 and Part 27.53 specify that the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10 log(P) dB.

The specification that emissions shall be attenuated below the transmitter power (P) by at least 43 + 10 log (P) dB, translates in the relevant power range (1 to 0.001 W) to -13 dBm. At 1 W the specified minimum attenuation becomes 43 dB and relative to a 30 dBm (1 W) carrier becomes a limit of -13 dBm. At 0.001 W (0 dBm) the minimum attenuation is 13 dB, which again yields a limit of -13 dBm. In this way a translation of the specification from relative to absolute terms is carried out.

### LTE Band 7

Part 27.53 m(4) For mobile digital stations, the attenuation factor shall be not less than  $40 + 10 \log (P)$  dB on all frequencies between the channel edge and 5 megahertz from the channel edge,  $43 + 10 \log (P)$  dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and  $55 + 10 \log (P)$  dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section.

#### **TEST CONFIGURATION**



### **TEST PROCEDURE**

- 1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter
- 2. Set EUT in maximum power output.
- 3. The band edges of low and high channels were measured.
- 4. Spectrum analyzer setting as follow:
  - RBW= no less than 1% of the OBW, VBW =3 \* RBW, Sweep time= Auto
- 5. Record the test plot.

#### **TEST MODE:**

Please refer to the clause 4.2

### **TEST RESULTS**

Refer to appendix D on the section 8 appendix report

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### 5.5. Conducted Spurious Emissions

#### **LIMIT**

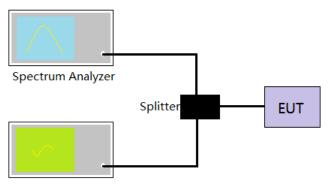
Part 24.238 and Part 22.917 and Part 27.53 specify that the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10 log(P) dB.

The specification that emissions shall be attenuated below the transmitter power (P) by at least 43 + 10 log (P) dB, translates in the relevant power range (1 to 0.001 W) to -13 dBm. At 1 W the specified minimum attenuation becomes 43 dB and relative to a 30 dBm (1 W) carrier becomes a limit of -13 dBm. At 0.001 W (0 dBm) the minimum attenuation is 13 dB, which again yields a limit of -13 dBm. In this way a translation of the specification from relative to absolute terms is carried out.

#### LTE Band 7

Part 27.53 m(4) For mobile digital stations, the attenuation factor shall be not less than 40 + 10 log (P) dB on all frequencies between the channel edge and 5 megahertz from the channel edge, 43 + 10 log (P) dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and 55 + 10 log (P) dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section. In addition, the attenuation factor shall not be less that 43 + 10 log (P) dB on all frequencies between 2490.5 MHz and 2496 MHz and 55 + 10 log (P) dB at or below 2490.5 MHz. Mobile Satellite Service licensees operating on frequencies below 2495 MHz may also submit a documented interference complaint against BRS licensees operating on channel BRS Channel 1 on the same terms and conditions as adjacent channel BRS or EBS licensees. Limit <-25 dBm

### **TEST CONFIGURATION**



#### Communication Tester

#### **TEST PROCEDURE**

- 1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter
- 2. Set EUT in maximum power output.
- 3. Spectrum analyzer setting as follow:

Below 1GHz, RBW=100KHz, VBW = 300KHz, Detector=Peak, Sweep time= Auto Above 1GHz, RBW=1MHz, VBW=3MHz, Detector=Peak, Sweep time= Auto Scan frequency range up to 10<sup>th</sup> harmonic.

4. Record the test plot.

#### **TEST MODE:**

Please refer to the clause 4.2

### **TEST RESULTS**

Refer to appendix E on the section 8 appendix report

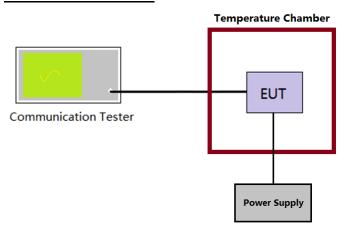
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## 5.6. Frequency stability VS Temperature measurement

### **LIMIT**

2.5ppm

### **TEST CONFIGURATION**



### **TEST PROCEDURE**

- 1. The equipment under test was connected to an external DC power supply and input rated voltage.
- 2. The EUT output port was connected to communication tester.
- 3. The EUT was placed inside the temperature chamber.
- 4. Turn EUT off and set the chamber temperature to –30°C. After the temperature stabilized for approximately 30 minutes recorded the frequency.
- 5. Repeat step 4 measure with 10°C increased per stage until the highest temperature of +50°C reached.

### **TEST MODE:**

Please refer to the clause 4.2

### **TEST RESULTS**

Refer to appendix F on the section 8 appendix report

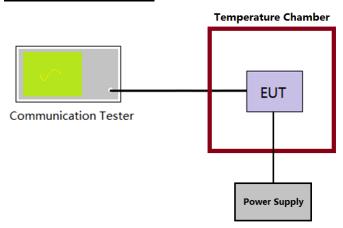
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### 5.7. Frequency stability VS Voltage measurement

### LIMIT

2.5ppm

### **TEST CONFIGURATION**



### **TEST PROCEDURE**

- 1. The equipment under test was connected to an external DC power supply and input rated voltage.
- 2. The EUT output port was connected to communication tester.
- 3. The EUT was placed inside the temperature chamber at 25°C
- 4. The power supply voltage to the EUT was varied ±15% of the nominal value measured at the input to the EUT
- 5. Record the maximum frequency change.

### **TEST MODE:**

Please refer to the clause 4.2

### **TEST RESULTS**

Refer to appendix F on the section 8 appendix report

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### 5.8. ERP and EIRP

### **LIMIT**

LTE Band 2/7/25/38/41: 2W(33dBm) EIRP

LTE Band 4/66: 1W(30dBm) EIRP LTE Band 5/26: 7W(38.50dBm) ERP

LTE Band 12/13/17/71: 3W(34.77dBm) ERP

### **TEST PROCEDURE**

- 1. According to the power tested in section 5.1, select the maximum power in each mode, and use the following formula to calculate the corresponding ERP/EIRP.
- 2. ERP = conducted power + Gain(dBd)
- 3. EIRP = conducted power + Gain(dBi)

**ERP = EIRP - 2.15** 

### **TEST RESULTS**

□ Passed	☐ Not Applicable
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Refer to appendix G on the section 8 appendix report

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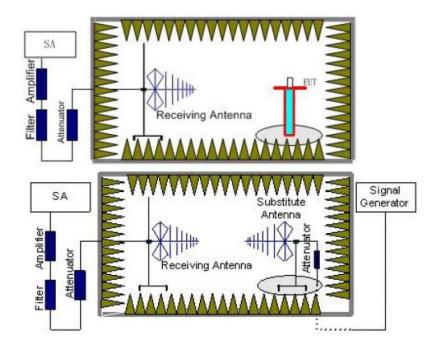
### 5.9. Radiated Spurious Emission

### **LIMIT**

LTE Band 2/4/5/12/13/17/25/26/66/71: -13dBm;

LTE Band 7/38/41: -25dBm

#### **TEST CONFIGURATION**



### **TEST PROCEDURE**

- 1. Place the EUT in the center of the turntable.
  - a) For radiated emissions measurements performed at frequencies less than or equal to 1 GHz, the EUT shall be placed on a RF-transparent table at a nominal height of 80 cm above the reference ground plane
  - b) For radiated measurements performed at frequencies above 1 GHz, the EUT shall be placed on an RF transparent table at a nominal height of 1.5 m above the ground plane.
- 2. Unless the EUT uses an integral antenna, the EUT shall be terminated with a non-radiating transmitter load. In cases where the EUT uses an adjustable antenna, the antenna shall be adjusted through typical positions and lengths to maximize emissions levels.
- 3. The EUT shall be tested while operating on the frequency per manufacturer specification. Set the transmitter to operate in continuous transmit mode.
- Receiver or Spectrum set as follow:

Below 1GHz, RBW=100kHz, VBW=300kHz, Detector=Peak, Sweep time=Auto

Above 1GHz, RBW=1MHz, VBW=3MHz, Detector=Peck, Sweep time=Auto

- 5. Each emission under consideration shall be evaluated:
  - a) Raise and lower the measurement antenna from 1 m to 4 m, as necessary to enable detection of the maximum emission amplitude relative to measurement antenna height.
  - b) Rotate the EUT through 360° to determine the maximum emission level relative to the axial position.
  - c) Return the turntable to the azimuth where the highest emission amplitude level was observed.
  - d) Vary the measurement antenna height again through 1 m to 4 m again to find the height associated with the maximum emission amplitude.
  - e) Record the measured emission amplitude level and frequency
- 6. Repeat step 5 for each emission frequency with the measurement antenna oriented in both the horizontal

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and vertical polarizations to determine the orientation that gives the maximum emissions amplitude.

- Set-up the substitution measurement with the reference point of the substitution antenna located as near
  as possible to where the center of the EUT radiating element was located during the initial EUT
  measurement.
- 8. Maintain the previous measurement instrument settings and test set-up, with the exception that the EUT is removed and replaced by the substitution antenna.
- 9. Connect a signal generator to the substitution antenna; locate the signal generator so as to minimize any potential influences on the measurement results. Set the signal generator to the frequency where emissions are detected, and set an output power level such that the radiated signal can be detected by the measurement instrument, with sufficient dynamic range relative to the noise floor.
- 10. For each emission that was detected and measured in the initial test
  - Vary the measurement antenna height between 1 m to 4 m to maximize the received (measured) signal amplitude.
  - b) Adjust the signal generator output power level until the amplitude detected by the measurement instrument equals the amplitude level of the emission previously measured directly in step 5 and step 6.
  - Record the output power level of the signal generator when equivalence is achieved in step b).
- 11. Repeat step 8 through step 10 with the measurement antenna oriented in the opposite polarization.
- 12. Calculate the emission power in dBm referenced to a half-wave dipole using the following equation:

Pe = Ps(dBm) - cable loss (dB) + antenna gain (dBd)

where

Pe = equivalent emission power in dBm

Ps = source (signal generator) power in dBm

NOTE—dBd refers to the measured antenna gain in decibels relative to a half-wave dipole.

13. Correct the antenna gain of the substitution antenna if necessary to reference the emission power to a half-wave dipole. When using measurement antennas with the gain specified in dBi, the equivalent dipole-referenced gain can be determined from:

gain (dBd) = gain (dBi) - 2.15 dB.

If necessary, the antenna gain can be calculated from calibrated antenna factor information

14. Provide the complete measurement results as a part of the test report.

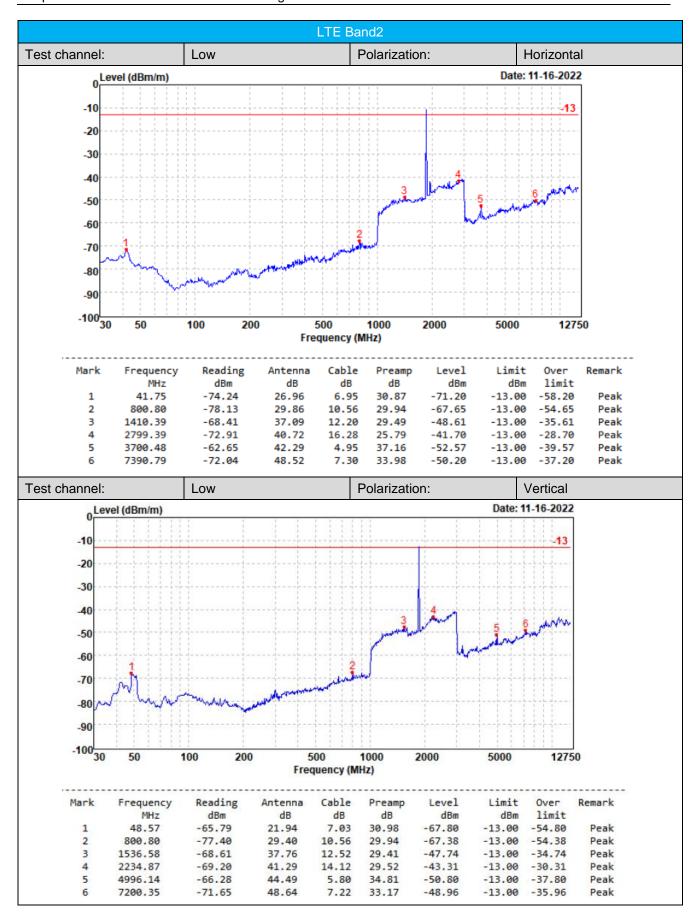
#### **TEST MODE:**

Please refer to the clause 4.2

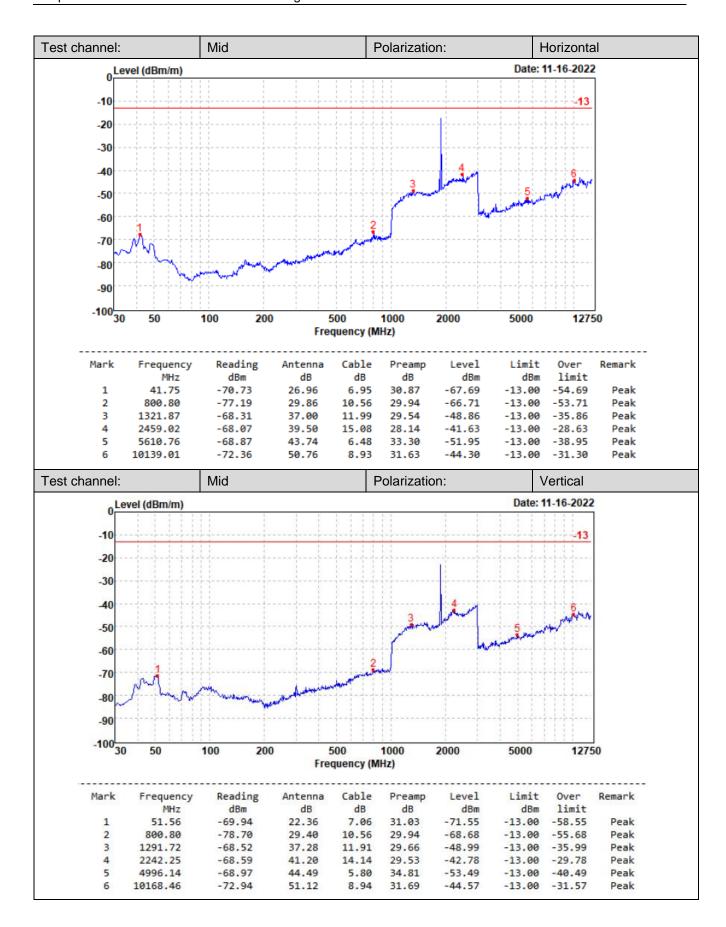
### **TEST RESULTS**

Note: only show the worse case for QPSK modulation.

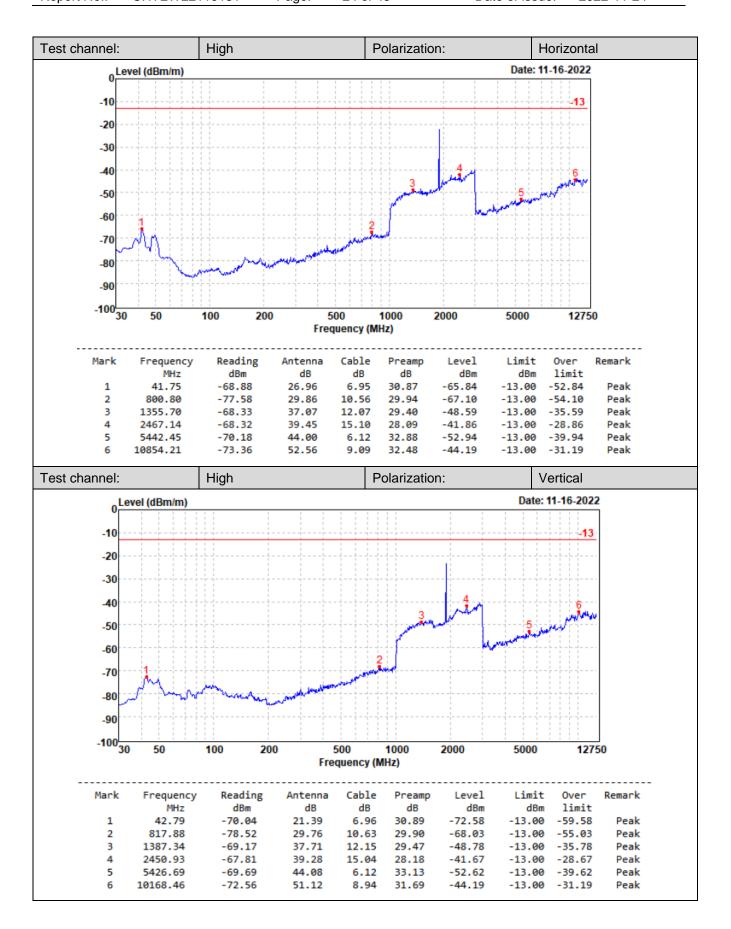
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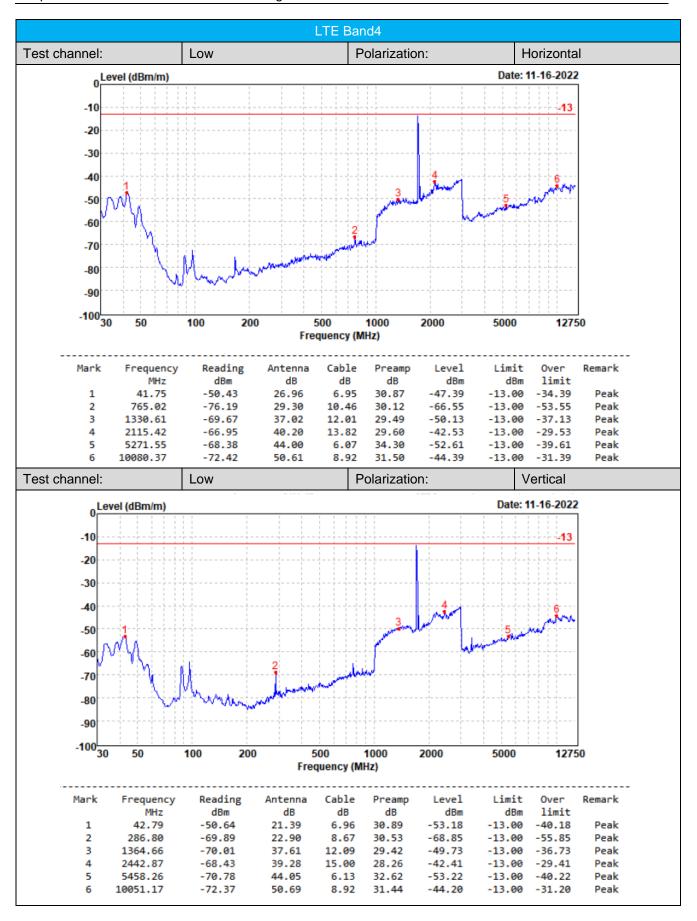
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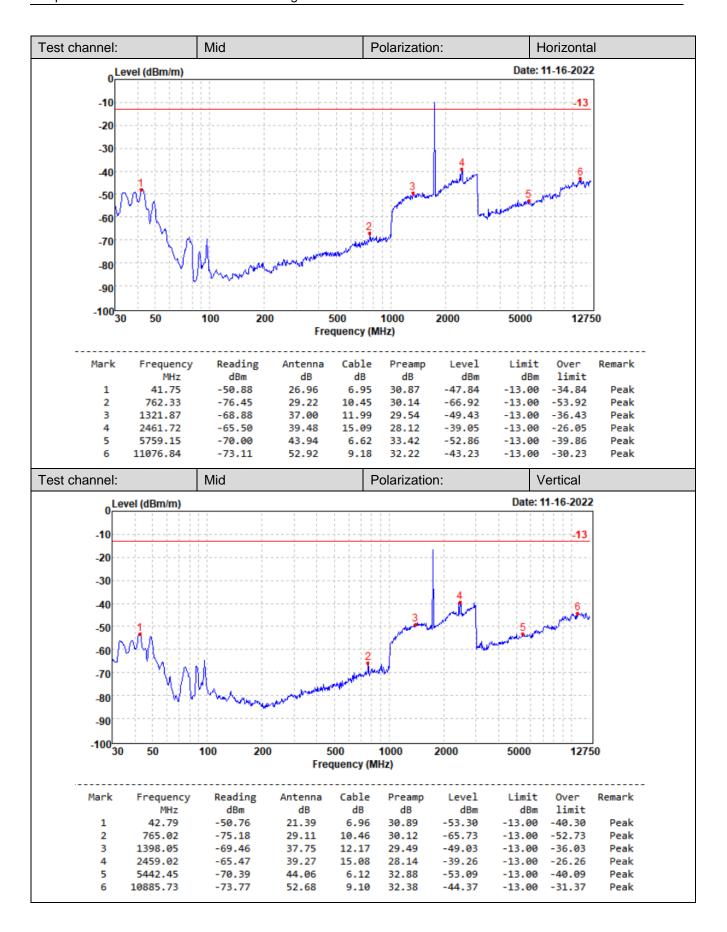
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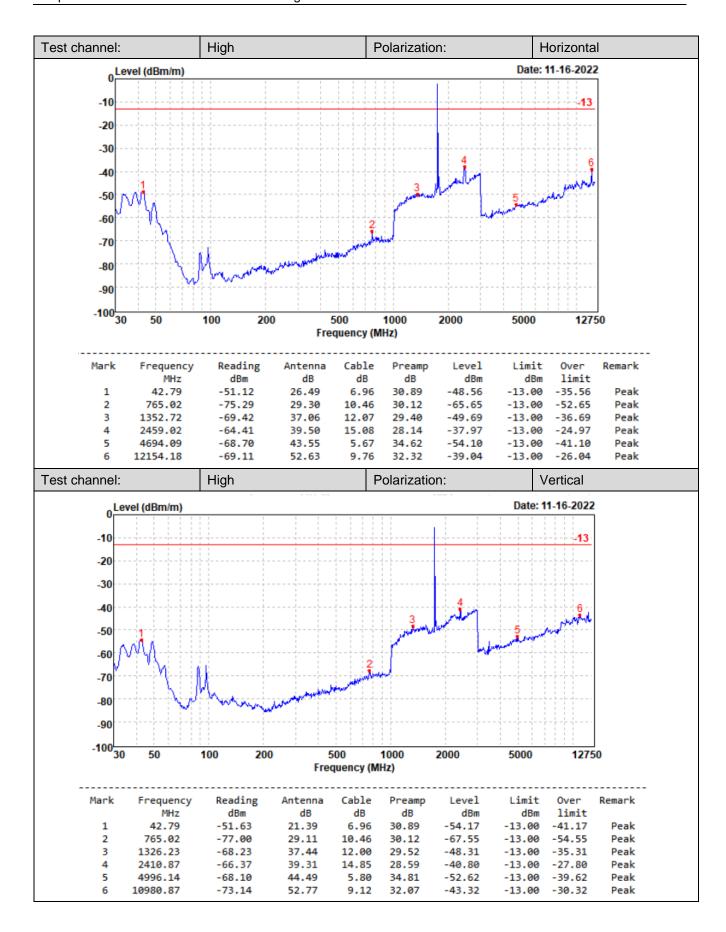
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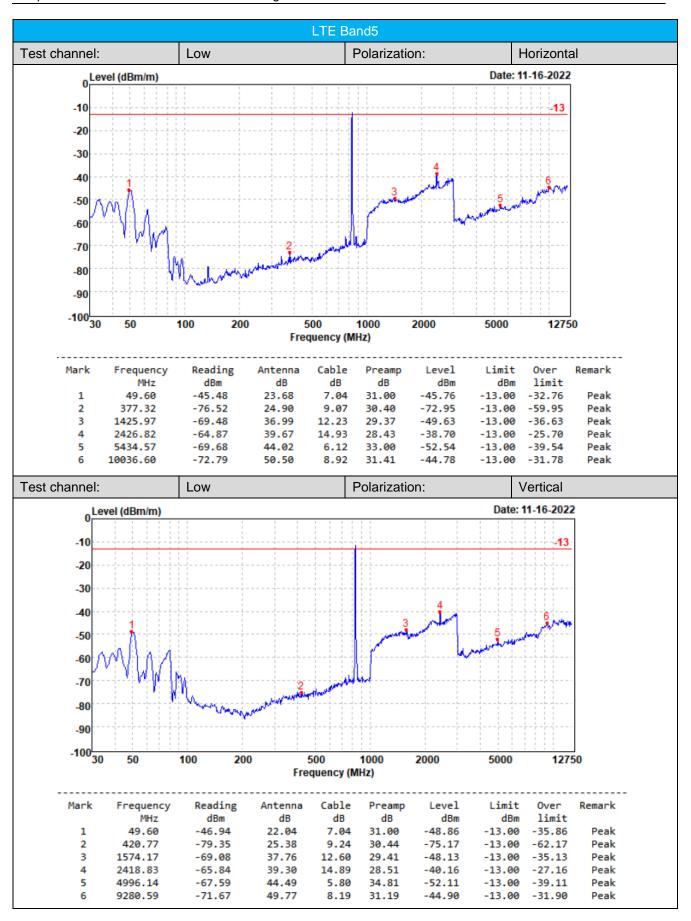
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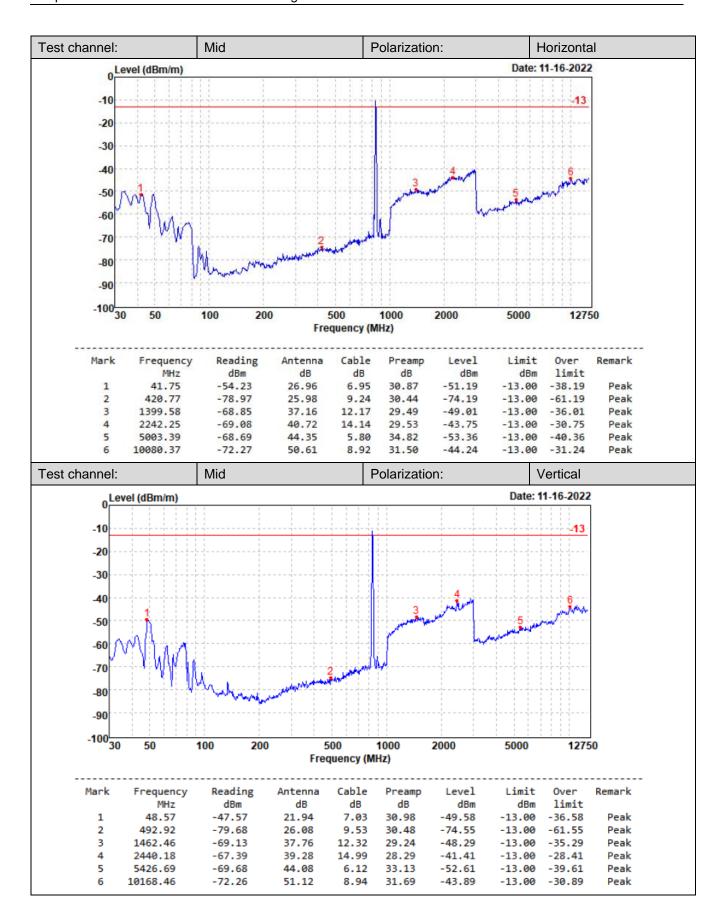
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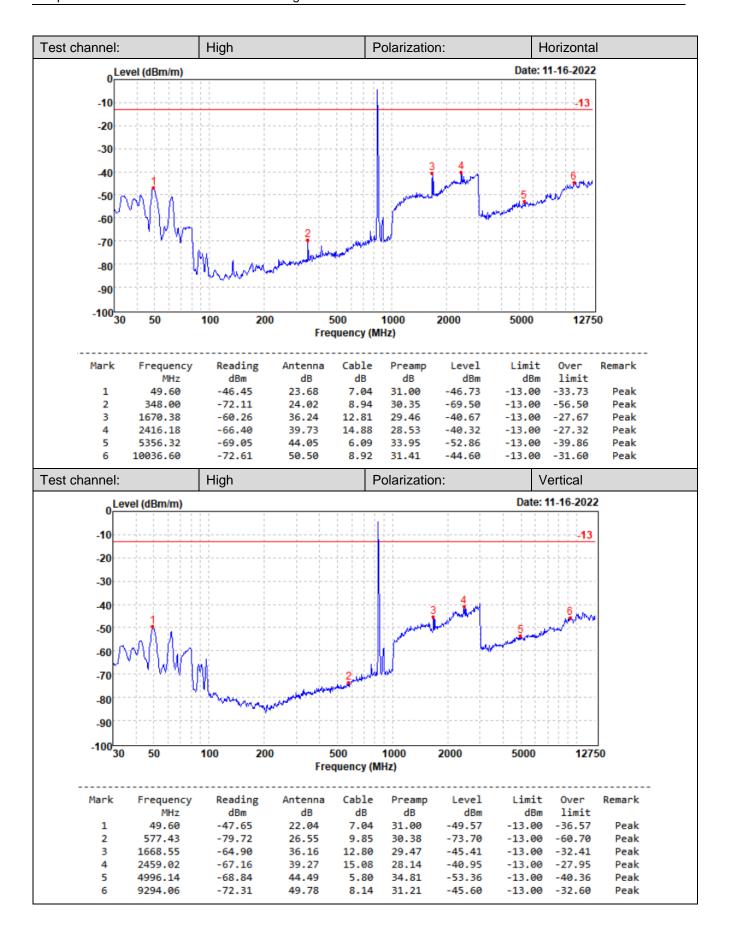
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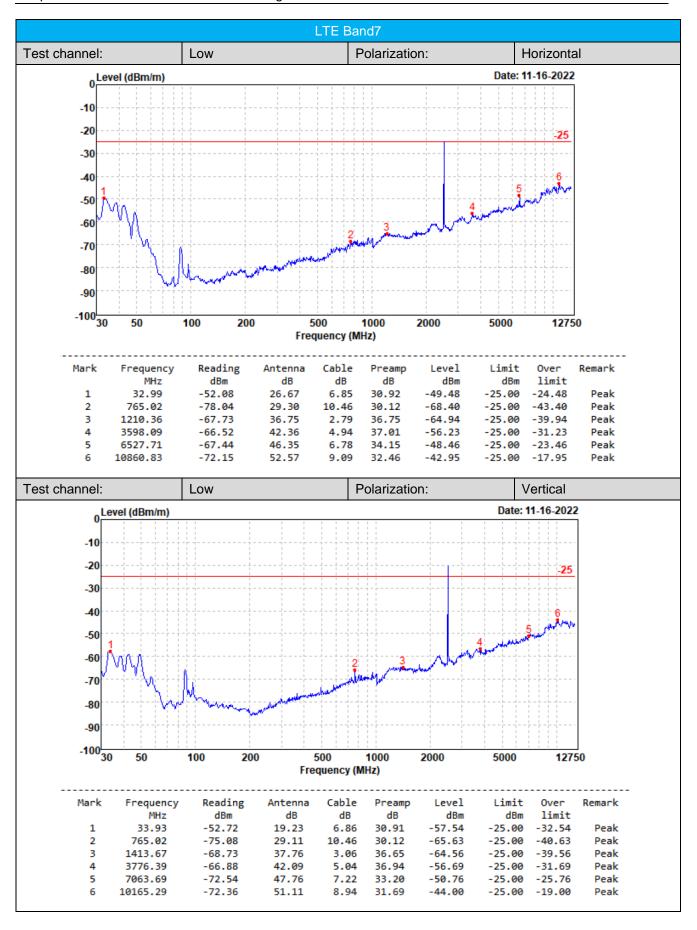
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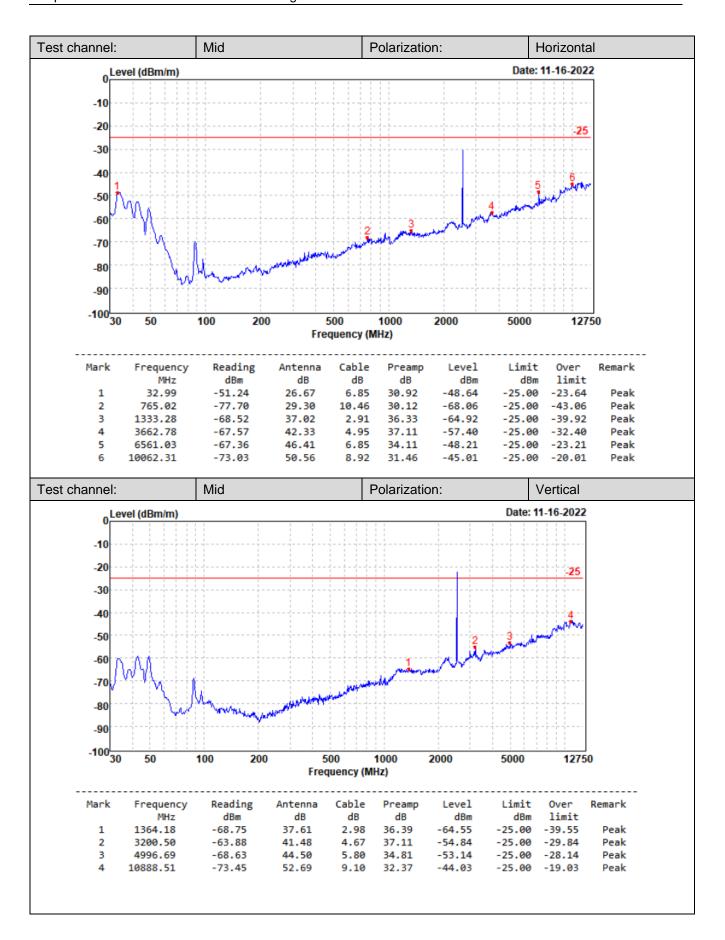
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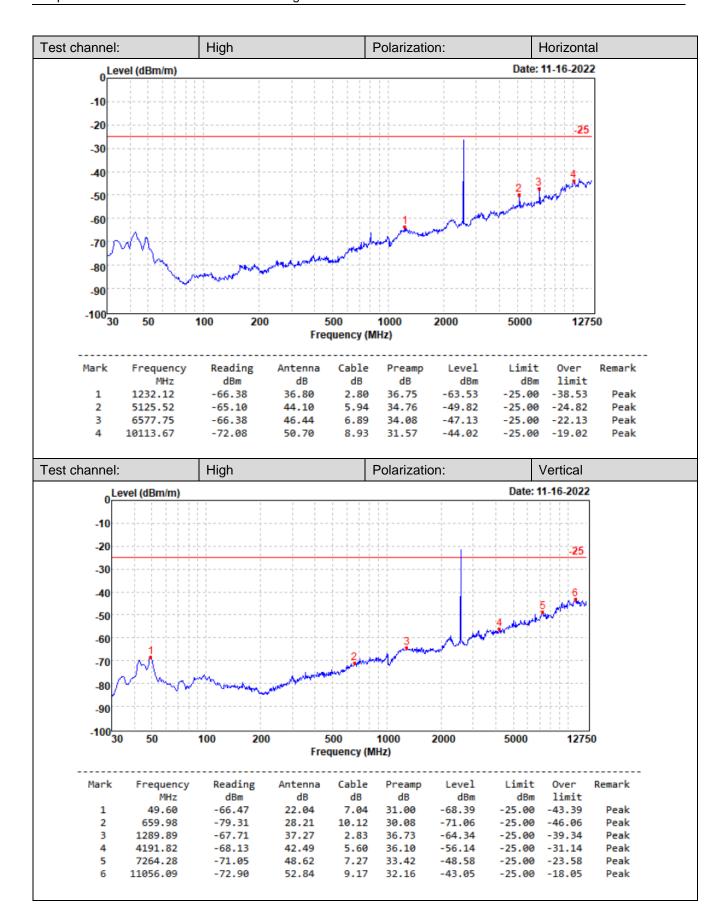
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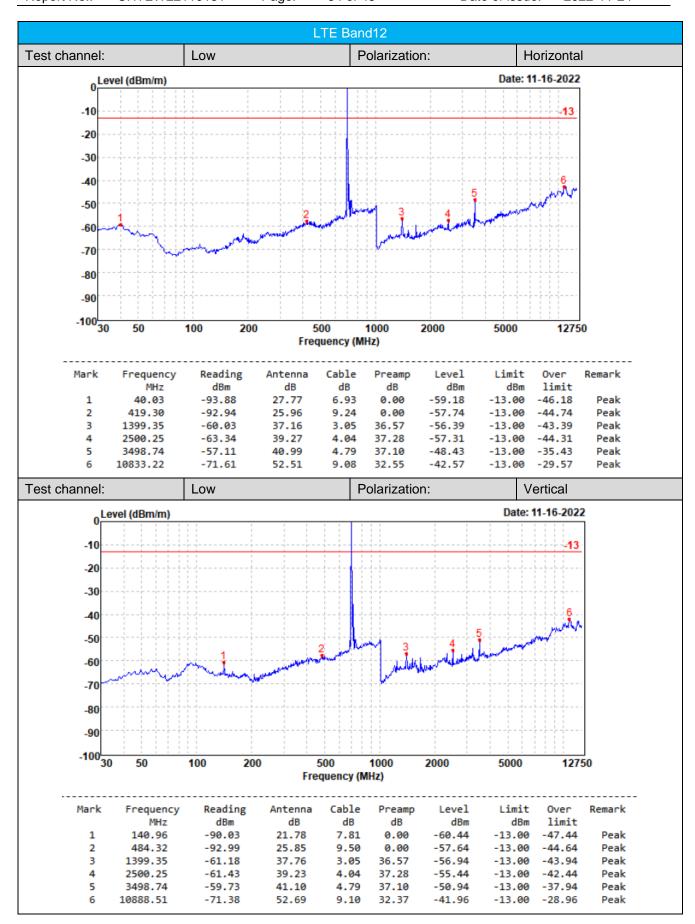
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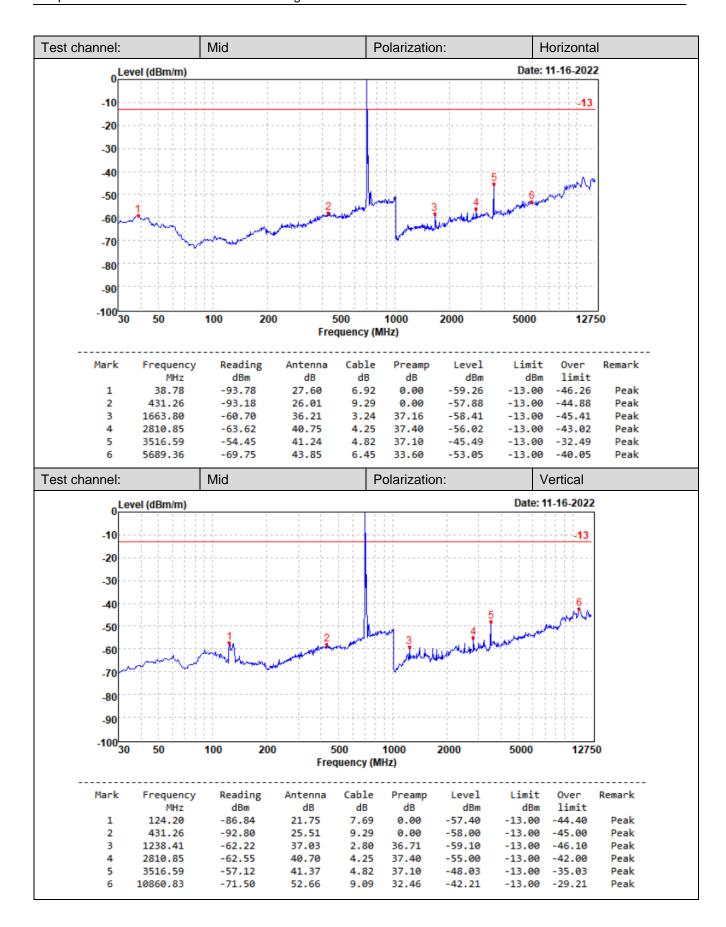
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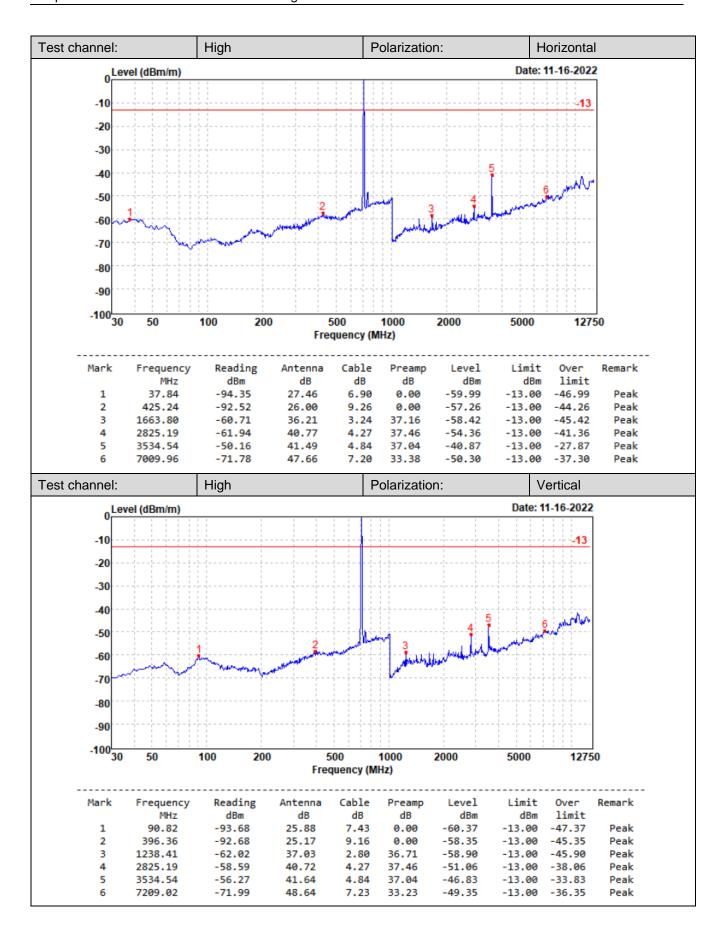
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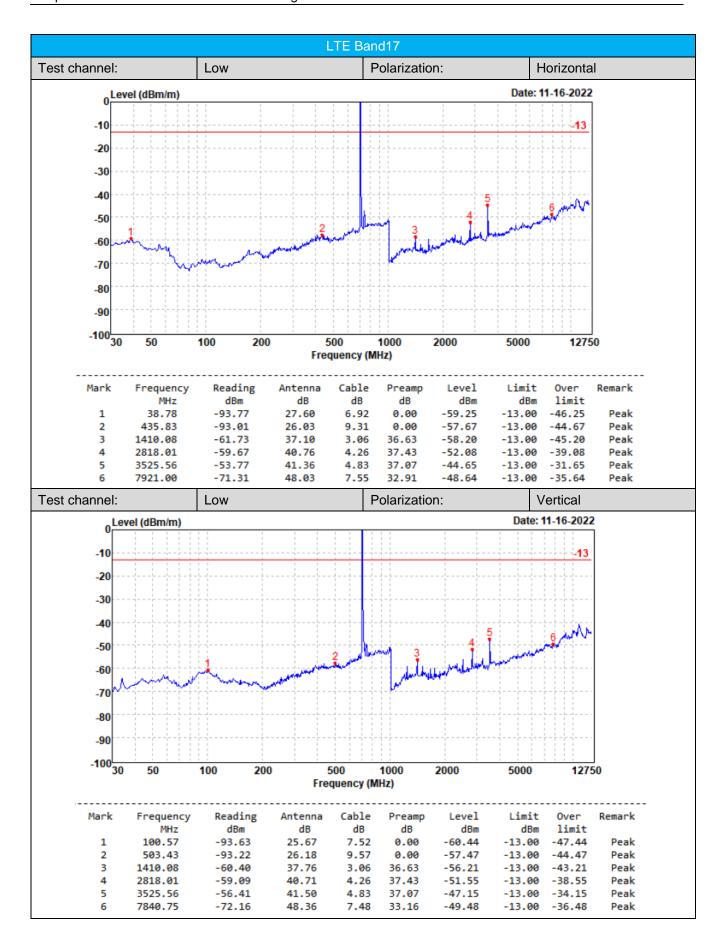
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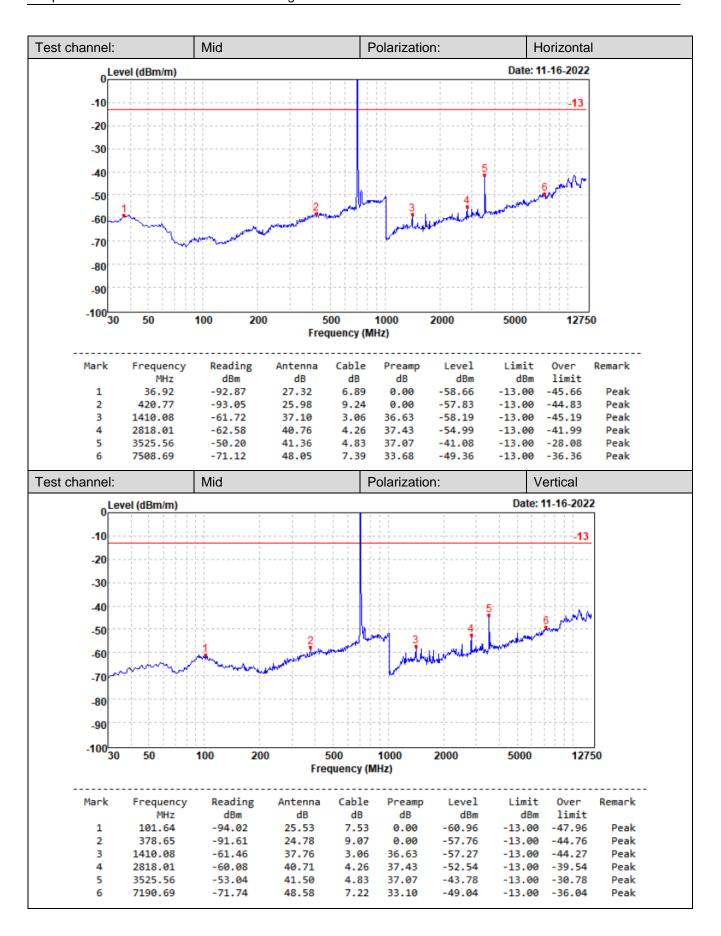
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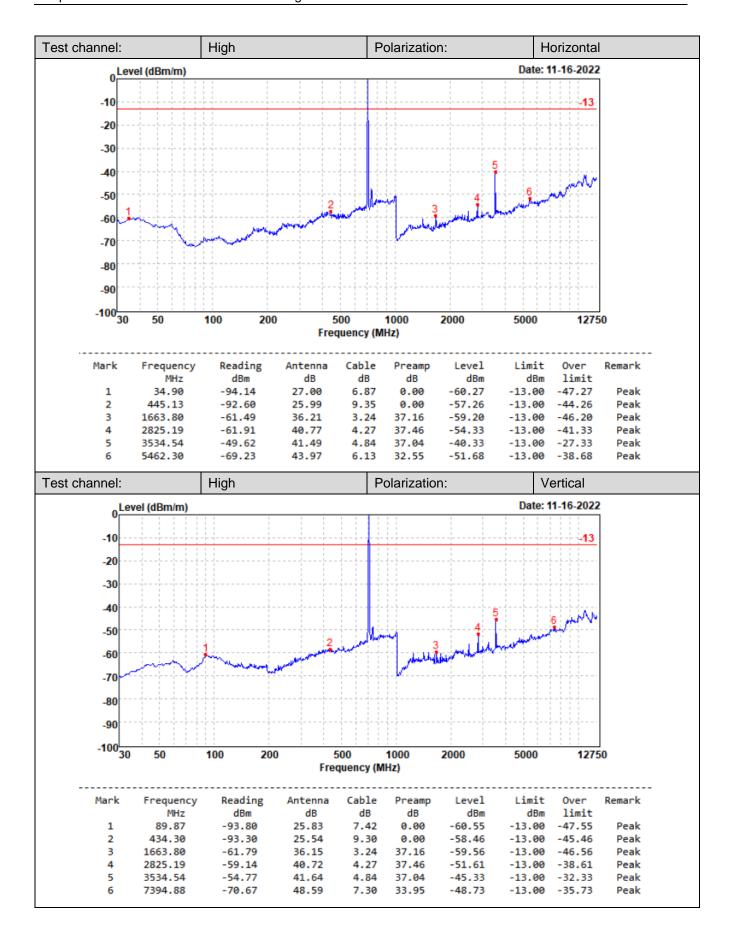
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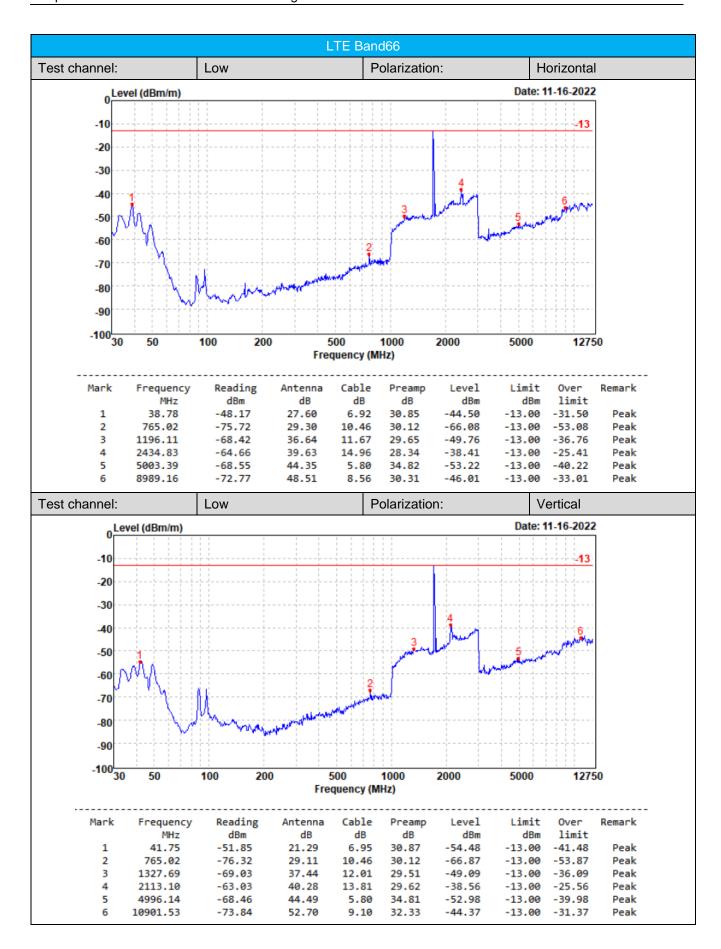
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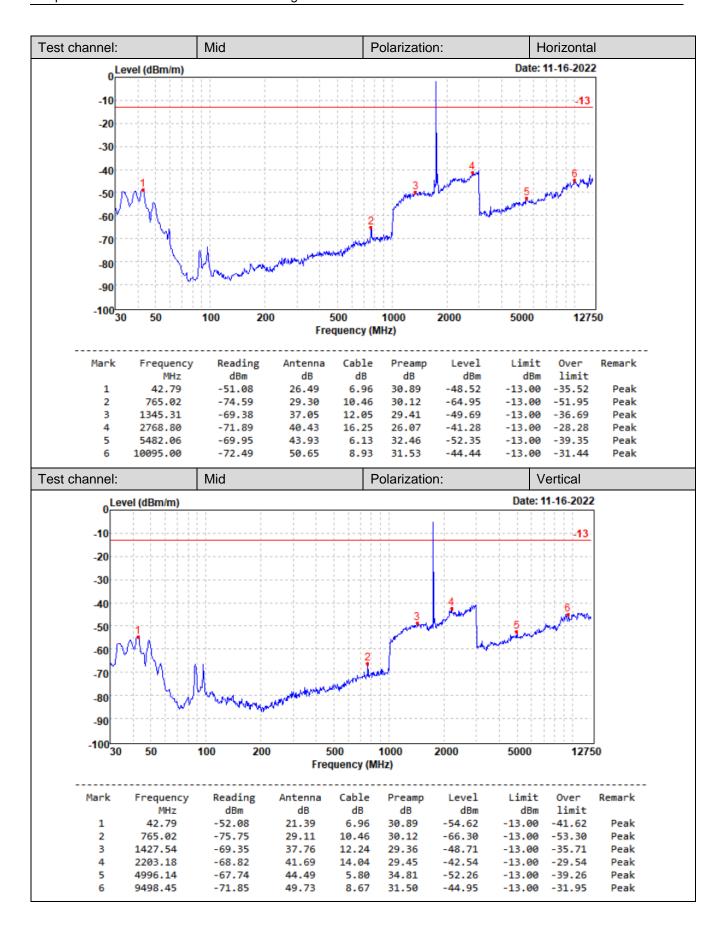
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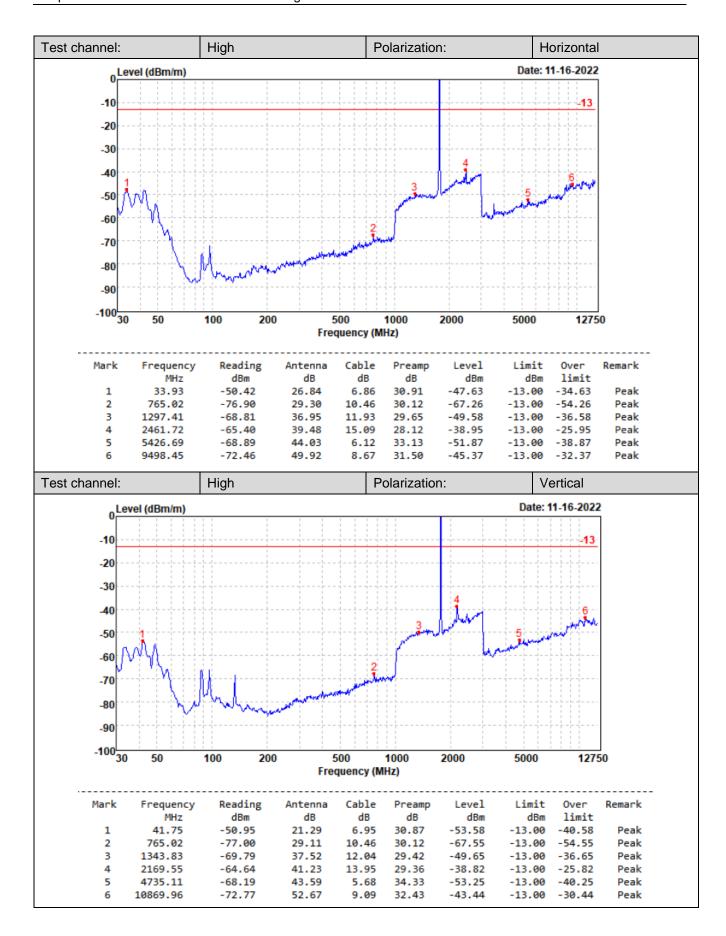
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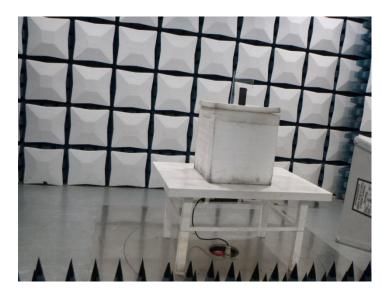
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## 6. TEST SETUP PHOTOS OF THE EUT





## 7. EXTERNAL AND INTERNAL PHOTOS OF THE EUT

Refer to the test report No.: CHTEW22110129

# 8. APPENDIX REPORT